

# MOSFET - N-Channel, SUPERFET®

600 V, 16 A, 260 m $\Omega$ 

# **FCP16N60, FCPF16N60**

### Description

SUPERFET MOSFET is **onsemi**'s first generation of high voltage super–junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on–resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SUPERFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.

#### **Features**

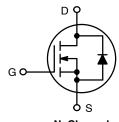
- $650 \text{ V} @ \text{T}_{\text{J}} = 150^{\circ}\text{C}$
- $R_{DS(on)} = 220 \text{ m}\Omega \text{ (Typ.)}$
- Ultra Low Gate Charge (Typ.  $Q_g = 55 \text{ nC}$ )
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 110 pF)
- 100% Avalanche Tested
- These are Pb-Free Devices

## **Applications**

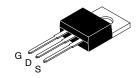
- Solar Inverter
- AC-DC Power Supply

V <sub>DS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
600 V	260 mΩ @ 10 V	16 A*	

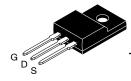
<sup>\*</sup>Drain current limited by maximum junction temperature.



N-Channel

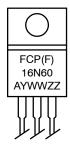


**TO-220-3LD CASE 340AT** 



TO-220 Fullpack, 3-Lead / TO-220F-3SG CASE 221AT

#### **MARKING DIAGRAM**



FCP(F)16N60 = Specific Device Code A = Assembly Location YWW = Date Code (Year & Week)

ZZ = Assembly Lot

1

#### **ORDERING INFORMATION**

Device	Package	Shipping
FCP16N60	TO-220-3	1000 Units / Tube
FCPF16N60	TO-220-3 FullPak	1000 Units / Tube

## **MOSFET MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter		FCP16N60	FCPF16N60	Unit
V <sub>DSS</sub>	Drain-Source Voltage		600		V
I <sub>D</sub>	Drain Current	– Continuous (T <sub>C</sub> = 25°C)	16	16*	А
		– Continuous (T <sub>C</sub> = 100°C)	10.1	10.1*	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	48	48*	А
V <sub>GSS</sub>	Gate-Source Voltage	•	±30		V
E <sub>AS</sub>	Single Pulsed Avalance	he Energy (Note 2)	450		mJ
I <sub>AR</sub>	Avalanche Current (No	ote 1)	16		Α
E <sub>AR</sub>	Repetitive Avalanche E	Energy (Note 1)	20.8		mJ
dv/dt	Peak Diode Recovery	dv/dt (Note 3)	4	4.5	
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	167	37.9	W
		– Derate Above 25°C	1.33	0.3	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage	Temperature Range	-55 to +150		°C
TL	Maximum Lead Tempe 1/8" from Case for 5 Se		300		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality stresses exceeding those listed in the Maximum Hatings table may damage it should not be assumed, damage may occur and reliability may be affected. \*Drain current limited by maximum junction temperature. 
1. Repetitive rating: pulse–width limited by maximum junction temperature. 
2.  $I_{AS} = 8 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$ ,  $R_G = 25 \Omega$ , starting  $T_J = 25 ^{\circ}\text{C}$ . 
3.  $I_{SD} \le 16 \text{ A}$ ,  $I_{SD} \le$ 

### THERMAL CHARACTERISTICS

Symbol	Parameter	FCP16N60	FCPF16N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	0.75	3.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS				-	-
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 25^{\circ}C$	600	_	-	V
		$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 150 ^{\circ} C$	-	650	-	V
$\Delta BV_{DSS}$	Breakdown Voltage Temperature	I <sub>D</sub> = 250 μA, Referenced to 25°C	-	0.6	-	V/°C
$\Delta T_{J}$	Coefficient					
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 16 A	-	700	_	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	-	-	10	
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V	-	-	±100	nA
ON CHARA	CTERISTICS					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A	-	0.22	0.26	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 8 A	-	11.5	-	S
DYNAMIC (	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	1730	2250	pF
C <sub>oss</sub>	Output Capacitance	]	-	960	1150	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]	-	85	-	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	45	60	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	110	-	pF
$Q_g$	Total Gate Charge at 10 V	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 16 A, V <sub>GS</sub> = 10 V	-	55	70	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	(Note 4)	-	10.5	13	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	]	-	28	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	1.7	-	Ω
SWITCHING	G CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 300 V, I <sub>D</sub> = 16 A, V <sub>GS</sub> = 10 V,	-	42	85	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$ (Note 4)	-	130	270	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	]	-	165	340	ns
t <sub>f</sub>	Turn-Off Fall Time	]	-	90	190	ns
DRAIN-SO	URCE DIODE CHARACTERISTICS AND	MAXIMUM RATINGS				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	16	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	_	48	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 16 A	-	_	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{SD} = 16 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	435	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	1	_	7.0	_	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature typical characteristics.

#### TYPICAL PERFORMANCE CHARACTERISTICS

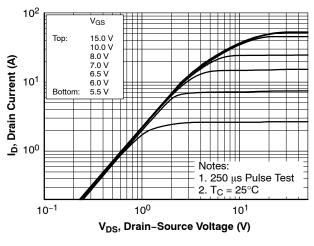


Figure 1. On-Region Characteristics

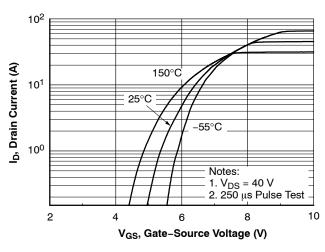


Figure 2. Transfer Characteristics

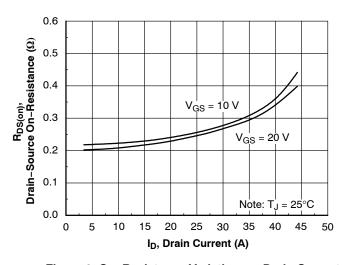


Figure 3. On-Resistance Variation vs. Drain Current and Gate voltage

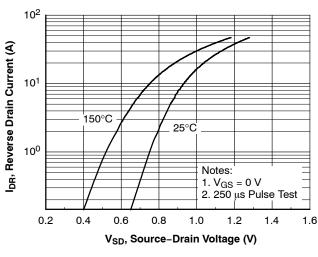


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

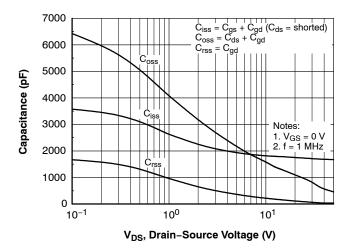


Figure 5. Capacitance Characteristics

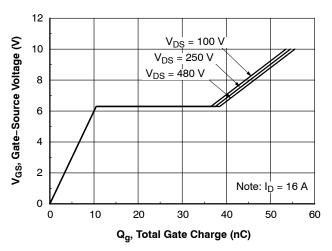
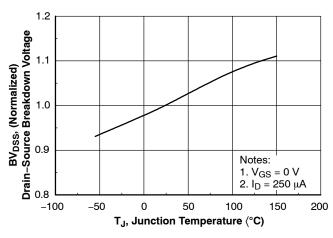


Figure 6. Gate Charge Characteristics

### TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



3.0 R<sub>DS(on)</sub>, (Normalized) Drain-Source On-Resistance 2.5 2.0 1.5 1.0 Notes: 0.5 1. V<sub>GS</sub> = 10 V 2. I<sub>D</sub> = 8 A 0.0 -100 -50 0 150 200 50 100 T<sub>J</sub>, Junction Temperature (°C)

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature

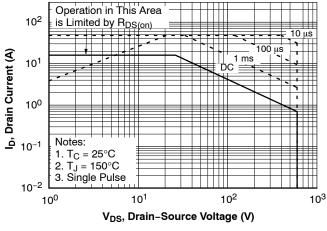


Figure 9. Maximum Safe Operating Area for FCP16N60

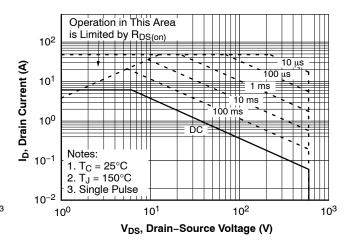


Figure 10. Maximum Safe Operating Area for FCPF16N60

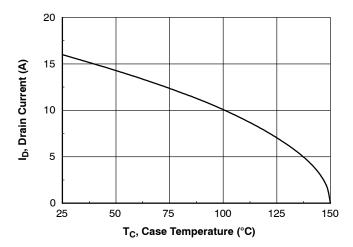


Figure 11. Maximum Drain Current vs. Case Temperature

+

# TYPICAL PERFORMANCE CHARACTERISTICS (continued)

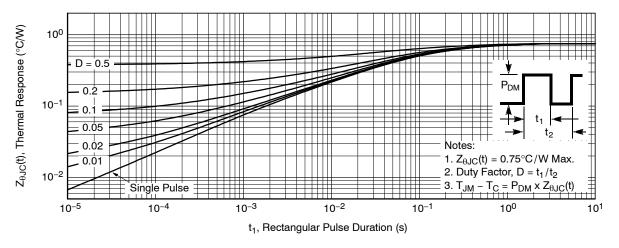


Figure 12. Transient Thermal Response Curve for FCP16N60

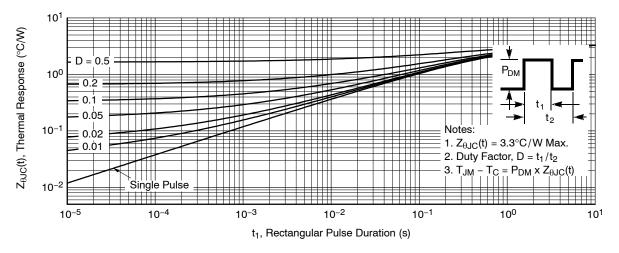


Figure 13. Transient Thermal Response Curve for FCPF16N60

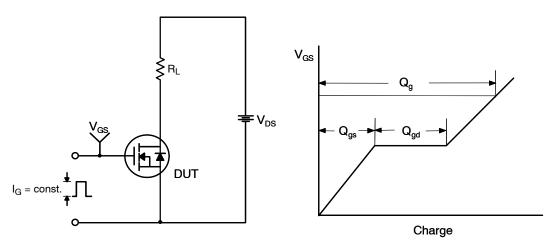


Figure 14. Gate Charge Test Circuit & Waveform

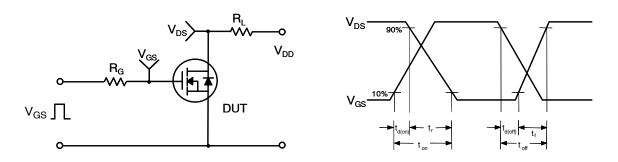


Figure 15. Resistive Switching Test Circuit & Waveforms

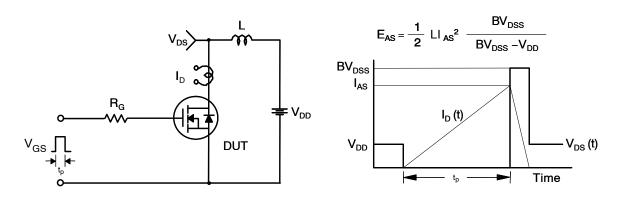
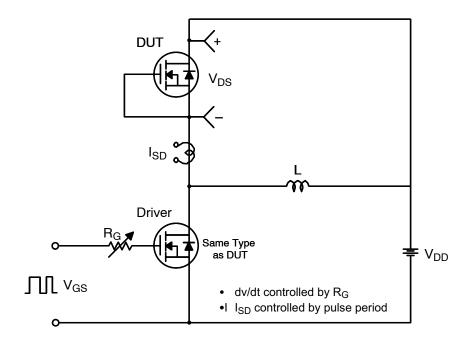


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms



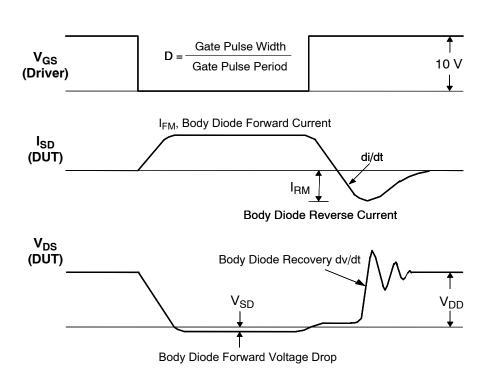
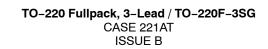
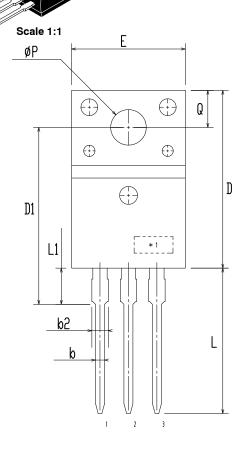


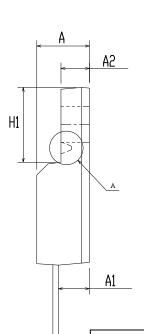
Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

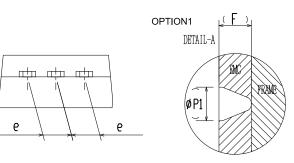
SUPERFET is a registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.



**DATE 19 JAN 2021** 







DIM	MILLIMITERS			
ויונע	MIN	NDM	MAX	
Α	4.50	4.70	4.90	
A1	2.56	2.76	2.96	
A2	2.34	2.54	2.74	
b	0.70	0.80	0.90	
b2	~	2	1.47	
С	0.45	0.50	0.60	
D	15.67	15.87	16.07	
D1	15.60	15.80	16.00	
E	9.96	10.16	10.36	
е	2.34	2.54	2.74	
F	~	0.84	2	
H1	6.48	6.68	6.88	
L	12.78	12.98	13.18	
L1	3.03	3.23	3.43	
ØΡ	2.98	3.18	3.38	
Ø P1	~	1.00	~	
Q	3.20	3.30	3.40	

MILLIMITEDS

#### NOTES:

- A. DIMENSION AND TOLERANCE AS ASME Y14.5-2009
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUCSIONS.

C

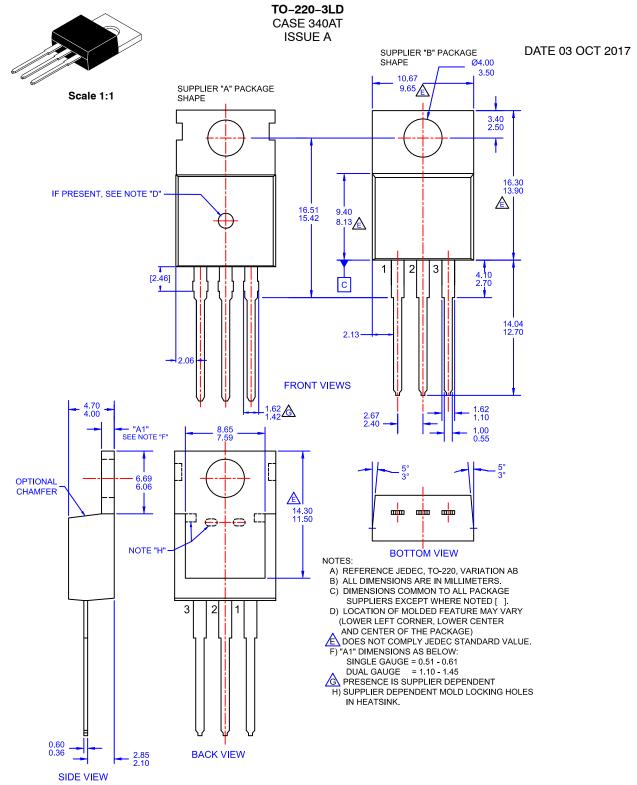
C. OPTION 1 - WITH SUPPORT PIN HOLE OPTION 2 - NO SUPPORT PIN HOLE

DOCUMENT NUMBER: 98AON67439E

Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

DESCRIPTION: TO-220 FULLPACK, 3-LEAD / TO-220F-3SG PAGE 1 OF 1

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.



DOCUMENT NUMBER:	98AON13818G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-220-3LD		PAGE 1 OF 1	

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems. or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales